

### **Description**

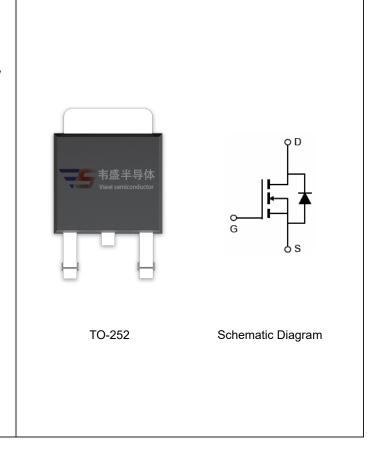
The VST15N240 uses **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of  $R_{\text{DS(ON)}}$  and  $Q_g$ . This device is ideal for high-frequency switching and synchronous rectification.

#### **General Features**

- $V_{DS}$  =150V, $I_D$  =45A  $R_{DS(ON)}$ =24m $\Omega$  (typical) @  $V_{GS}$ =10V
- Excellent gate charge x R<sub>DS(on)</sub> product(FOM)
- Very low on-resistance R<sub>DS(on)</sub>
- 175 °C operating temperature
- Pb-free lead plating
- 100% UIS tested

### **Application**

- LED backlighting
- Ideal for high-frequency switching and synchronous rectification



**Package Marking and Ordering Information** 

<b>Device Marking</b>	Device	Device Package	Reel Size	Tape width	Quantity
VST15N240-T2	VST15N240	TO-252	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (T<sub>4</sub>=25 °C unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	150	V	
Gate-Source Voltage	V <sub>GS</sub>	±20	V	
Drain Current-Continuous	I <sub>D</sub>	45	А	
Drain Current-Continuous(T <sub>C</sub> =100 °C)	I <sub>D</sub> (100°C)	31.8	А	
Pulsed Drain Current	I <sub>DM</sub>	180	А	
Maximum Power Dissipation	P <sub>D</sub>	130	W	
Derating factor		0.87	W/°C	
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	200	mJ	
Operating Junction and Storage Temperature Range	$T_{J}$ , $T_{STG}$	-55 To 175	$^{\circ}$	

#### **Thermal Characteristic**

Thermal Résistance, Junction-to-Case <sup>(Note 2)</sup>	R <sub>0</sub> JC	1.15	°C/W
--	-------------------	------	------



# Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	<u>.</u>					
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	150	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =150V,V <sub>GS</sub> =0V	-	-	1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)	·					
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	2.0	3.1	4.0	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	24	27.5	mΩ
Gate resistance	R <sub>G</sub>		-	6.2	-	Ω
Forward Transconductance	<b>G</b> FS	V <sub>DS</sub> =5V,I <sub>D</sub> =20A	15	-	-	S
Dynamic Characteristics (Note4)	·					
Input Capacitance	C <sub>lss</sub>		-	1300		PF
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =75 $V$ , $V_{GS}$ =0 $V$ , F=1.0MHz	-	162		PF
Reverse Transfer Capacitance	C <sub>rss</sub>	Γ-1.UIVIΠZ	-	11.7		PF
Switching Characteristics (Note 4)	·		<u>.</u>			
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =75V, R <sub>L</sub> =7.5Ω	-	10	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	6.5	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10 $V$ , $R_{G}$ =3 $\Omega$	-	16	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	7	-	nS
Total Gate Charge	Qg	75// 204	-	21.1	-	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ =75 $V$ , $I_{D}$ =20 $A$ , $V_{GS}$ =10 $V$	-	8	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> -10V	-	4.6	-	nC
Drain-Source Diode Characteristics	<u>.</u>					
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =20A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	45	Α
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25^{\circ}C, I_F = I_S$	-	30	-	nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	135	-	nC

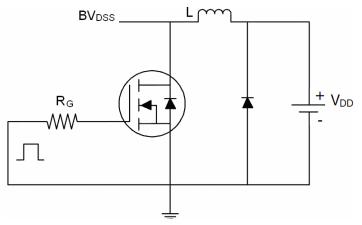
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board,  $t \le 10$  sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25  $^{\circ}\text{C}$  ,V\_DD=75V,V\_G=10V,L=0.5mH,Rg=25 $\Omega$

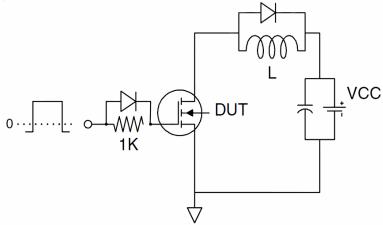


## **Test Circuit**

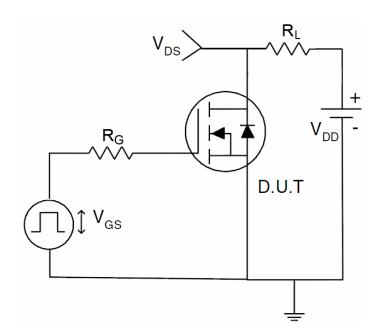
# 1) E<sub>AS</sub> test Circuit



## 2) Gate charge test Circuit

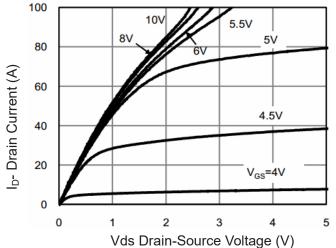


## 3) Switch Time Test Circuit

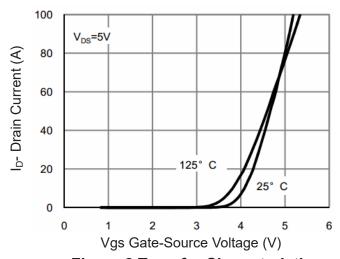




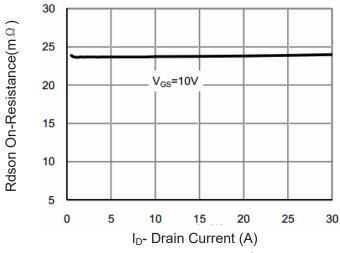




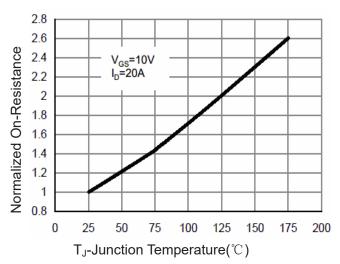
**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 



**Figure 3 Rdson- Drain Current** 



**Figure 4 Rdson-Junction Temperature** 

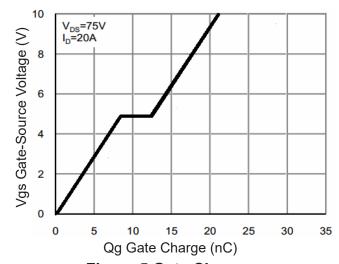


Figure 5 Gate Charge

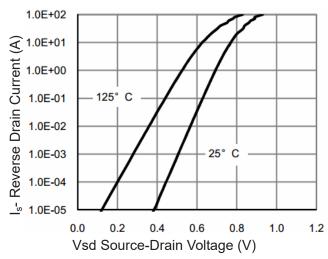


Figure 6 Source- Drain Diode Forward



lp- Drain Current (A)

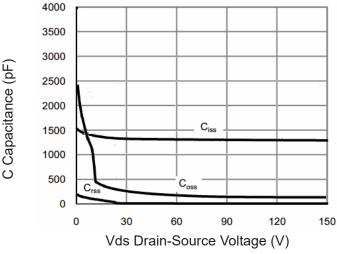


Figure 7 Capacitance vs Vds

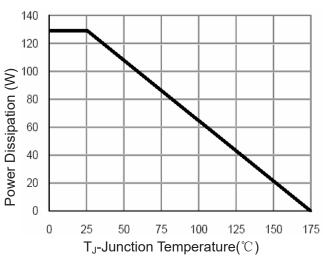


Figure 9 Power De-rating

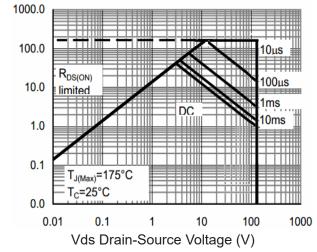


Figure 8 Safe Operation Area

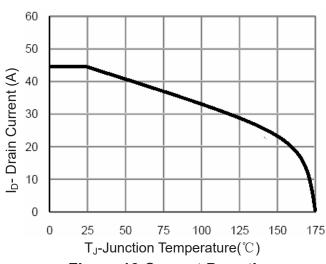
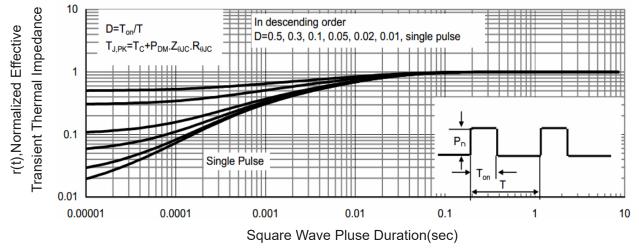


Figure 10 Current De-rating



**Figure 11 Normalized Maximum Transient Thermal Impedance**